## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | YAMAMURA ET AL. | Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	. Name	Classification
	Α	US-			
	В	US-			
	C	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-		·	
	Н	US-	7 2		
	ł	US-			
	J	US-			
	K	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z	JP08-085775	02-1996	Japan	Niwa et al	
	0	JP08-208832	08-1996	Japan	Niwa et al	
	Р	JP08-218296	08-1996	Japan	Niwa et al	
	Q	JP08-277385	10-1996	Japan	Niwa et al	
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	×	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.